

MOSFET - Power, Single N-Channel, SO-8 FL 30 V, 127 A **NVMFS4C05N**, **NVMFS4C305N**

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- NVMFS4C05NWF Wettable Flanks Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

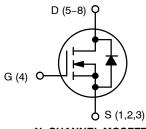
Parameter		Symbol	Value	Unit	
Drain-to-Source Voltage		V_{DSS}	30	V	
Gate-to-Source Voltage		V_{GS}	±20	V	
Continuous Drain Current R _{0.1A}		T _A = 25°C	_	27.2	Α
(Notes 1, 2 and 4)		T _A = 80°C	l _D	21.6	
Power Dissipation $R_{\theta JA}$ (Notes 1, 2 and 4)		T _A = 25°C	P _D	3.61	W
Continuous Drain Current R _{0JC} (Notes 1, 2, 3 and 4)	Steady State	T _C = 25°C		127	•
Continuous Drain Current R _{0JC} (Notes 1, 2, 3 and 4)		T _C = 80°C	l _D	101	А
Power Dissipation $R_{\theta JC}$ (Notes 1, 2, 3 and 4)		T _C = 25°C	P _D	79	W
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \ \mu s$		I _{DM}	174	Α
Operating Junction and Storage Temperature		T _J , T _{STG}	–55 to +175	°C	
Source Current (Body Diode)		IS	72	Α	
Single Pulse Drain-to-Source Avalanche Energy ($T_J = 25^{\circ}C$, $I_L = 29 A_{pk}$, $L = 0.1 mH$)		E _{AS}	42	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)				260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using 650 mm², 2 oz Cu pad.
- 3. Assumes heat-sink sufficiently large to maintain constant case temperature independent of device power.
- Continuous DC current rating. Maximum current for pulses as long as one second is higher but dependent on pulse duration and duty cycle.

1

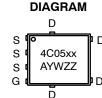
V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
30 V	2.8 mΩ @ 10 V	127 A
30 V	4.0 mΩ @ 4.5 V	121 A



N-CHANNEL MOSFET







MARKING

SO-8 FL DFNW5 CASE 488AA CASE 507BE

ZZ

4C05N = Specific Device Code for NVMFS4C05N

4C05WF= Specific Device Code of NVMFS4C05NWF

= Assembly Location

= Year W = Work Week = Lot Traceabililty

ORDERING INFORMATION

Device	Package	Shipping [†]
NVMFS4C05NT1G, NVMFS4C305NT1G-YE, NVMFS4C305NET1G-YE	SO-8 FL (Pb-Free)	1500 / Tape & Reel
NVMFS4C05NT3G	SO-8 FL (Pb-Free)	5000 / Tape & Reel
NVMFS4C05NWFT1G, NVMFS4C05NWFET1G	DFNW5 (Pb-Free)	1500 / Tape & Reel
NVMFS4C05NWFT3G	DFNW5 (Pb-Free)	5000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit	
Junction-to-Case (Drain)	$R_{ heta JC}$	1.9	°C ///	
Junction-to-Ambient - Steady State (Note 5)	$R_{ heta JA}$	41.6	°C/W	

^{5.} Surface-mounted on FR4 board using 650 mm², 2 oz Cu pad.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
OFF CHARACTERISTICS		<u>I</u>						
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V	
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				12		mV/°C	
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	T _J = 25°C			1.0	μΑ	
			13 - 120 0			10	μΛ	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS}$; = ±20 V			±100	nA	
ON CHARACTERISTICS (Note 6)								
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 250 μΑ	1.3		2.2	V	
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-5.1		mV/°C	
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		2.3	2.8	~ 0	
		V _{GS} = 4.5 V	I _D = 30 A		3.3	4.0	mΩ	
Forward Transconductance	9FS	V _{DS} = 1.5 V, I	_D = 15 A		68		S	
Gate Resistance	R_{G}	T _A = 25°	C	0.3	1.0	2.0	Ω	
CHARGES AND CAPACITANCES					•	•	•	
Input Capacitance	C _{ISS}				1972			
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V			1215		pF	
Reverse Transfer Capacitance	C _{RSS}				59			
Capacitance Ratio	C _{RSS} /C _{ISS}	V _{GS} = 0 V, V _{DS} = 15	5 V, f = 1 MHz		0.030			
Total Gate Charge	Q _{G(TOT)}				14			
Threshold Gate Charge	Q _{G(TH)}				3.3		1	
Gate-to-Source Charge	Q _{GS}	V _{GS} = 4.5 V, V _{DS} = 15 V; I _D = 30 A			6.0		nC	
Gate-to-Drain Charge	Q_{GD}				5.0			
Gate Plateau Voltage	V_{GP}				3.1		V	
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V; I _D = 30 A			30		nC	
SWITCHING CHARACTERISTICS (Note 7				•	•	•	•	
Turn-On Delay Time	t _{d(ON)}				11			
Rise Time	t _r	$V_{GS} = 4.5 \text{ V}, V_{D}$	_S = 15 V,		32		ns	
Turn-Off Delay Time	t _{d(OFF)}	$V_{GS} = 4.5 \text{ V}, V_{D}$ $I_{D} = 15 \text{ A}, R_{G}$	= 3.0 Ω		21			
Fall Time	t _f				7.0			
Turn-On Delay Time	t _{d(ON)}				8.0			
Rise Time	t _r	V_{GS} = 10 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			26		ns	
Turn-Off Delay Time	t _{d(OFF)}				26			
Fall Time	t _f				5.0			
DRAIN-SOURCE DIODE CHARACTERIS	STICS	-		-	-	-	-	
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V$,	T _J = 25°C		0.77	1.1	V	
		$I_{S} = 10 \text{ A}$ $T_{J} = 125^{\circ}\text{C}$			0.62		, v	
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A}/\mu\text{s,}$ $I_{S} = 30 \text{ A}$			40.2			
Charge Time	t _a				20.3		ns	
Discharge Time	t _b				19.9			
Reverse Recovery Charge	Q_{RR}				30.2		nC	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

6. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

7. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

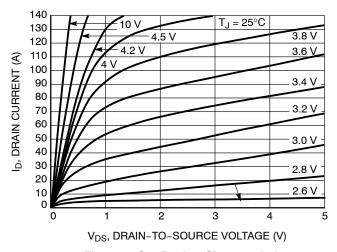


Figure 1. On-Region Characteristics

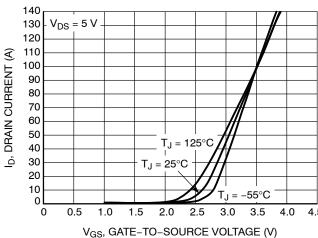


Figure 2. Transfer Characteristics

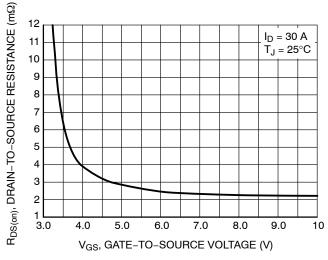


Figure 3. On-Resistance vs. V_{GS}

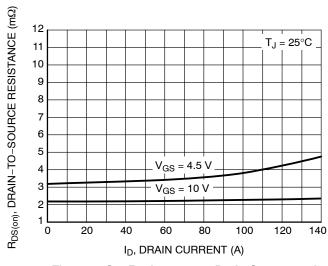


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

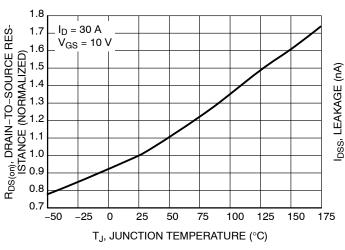


Figure 5. On–Resistance Variation with Temperature

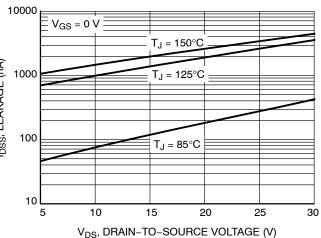


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

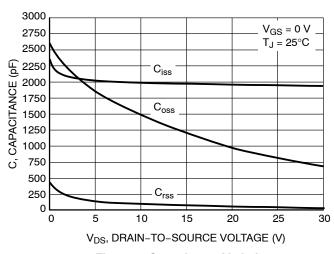


Figure 7. Capacitance Variation

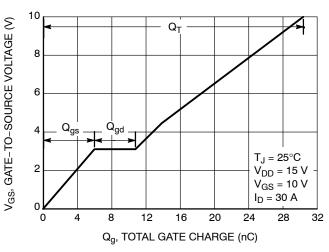


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

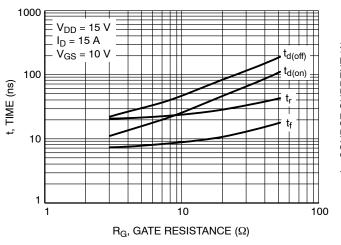


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

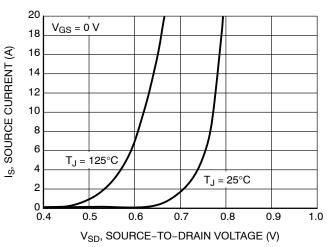


Figure 10. Diode Forward Voltage vs. Current

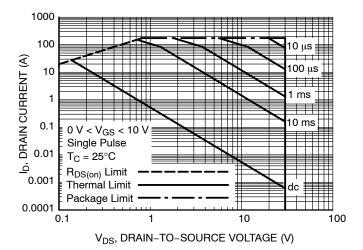


Figure 11. Maximum Rated Forward Biased Safe Operating Area

TYPICAL CHARACTERISTICS

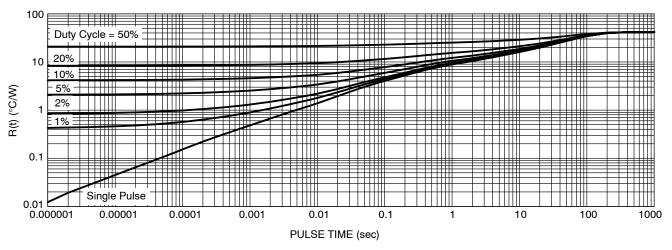


Figure 12. Thermal Response

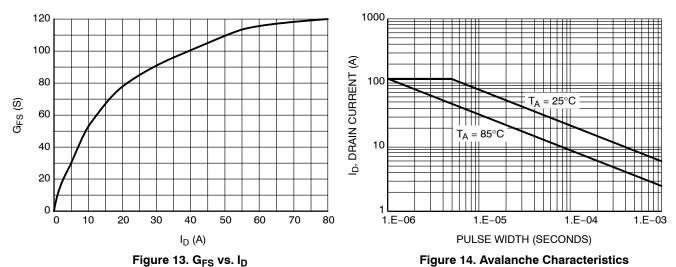


Figure 14. Avalanche Characteristics





DFN5 5x6, 1.27P (SO-8FL) CASE 488AA **ISSUE N**

DATE 25 JUN 2018

NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: MILLIMETER.
 3. DIMENSION D1 AND E1 DO NOT INCLUDE
- MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	0.90	1.00	1.10	
A1	0.00		0.05	
b	0.33	0.41	0.51	
С	0.23	0.28	0.33	
D	5.00	5.15	5.30	
D1	4.70	4.90	5.10	
D2	3.80	4.00	4.20	
E	6.00	6.15	6.30	
E1	5.70	5.90	6.10	
E2	3.45	3.65	3.85	
е	1.27 BSC			
G	0.51	0.575	0.71	
K	1.20	1.35	1.50	
L	0.51	0.575	0.71	
L1	0.125 REF			
М	3.00	3.40	3.80	
θ	0 °		12 °	

GENERIC MARKING DIAGRAM*



XXXXXX = Specific Device Code

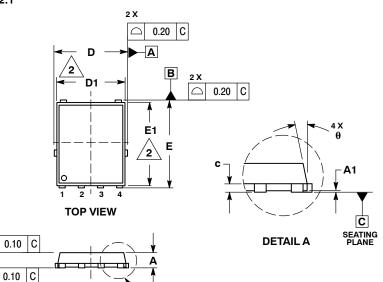
= Assembly Location Α

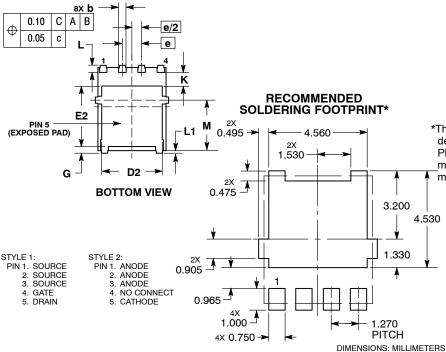
= Lot Traceability

Υ = Year W = Work Week

ZZ

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





DETAIL A

SIDE VIEW

*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

DOCUMENT NUMBER:	98AON14036D	Electronic versions are uncontrolled except when accessed directly from the Document Repositor Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1	

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MILLIMETERS



PIN 1

IDENTIFIER

DFNW5 4.90x5.90x1.00, 1.27P

CASE 507BE **ISSUE B**

A

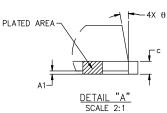
DATE 19 SEP 2024

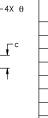
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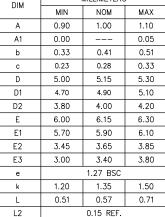
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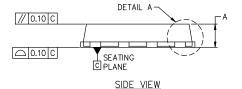
NOTES:

- DIMENSIONING AND TOLERANCING CONFORM TO ASME Y14.5M-2018. 1.
- ALL DIMENSIONS ARE IN MILLIMETERS.
- DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- THIS PACKAGE CONTAINS WETTABLE FLANK DESIGN FEATURES TO AID IN FILLET FORMATION ON THE LEADS DURING MOUNTING.







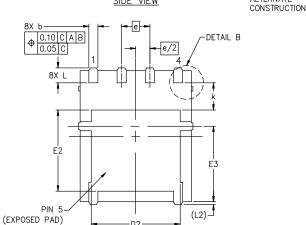


TOP VIEW

ALTERNATE



THE BOTTOM OF TIE BAR.



-D2

BOTTOM VIEW



2X 0.50-4.56 -1.53-2X 0.48 PACKAGE 3.20 OUTLINE 1.33 2X 0.91-4X 1.00 0.97 1.27 PIN 1 ID PITCH 4X 0.75

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RECOMMENDED MOUNTING FOOTPRINT* *FOR ADDITIONAL INFORMATION ON OUR Pb—FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ONSEMI SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

GENERIC MARKING DIAGRAM*



= Assembly Location Α Υ

= Year W = Work Week 77 = Lot Traceability

XXXXXX = Specific Device Code *This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION: DFNW5 4.90x5.90x1.00, 1.27P **PAGE 1 OF 1**

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